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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	6627
Number of Logic Elements/Cells	132540
Total RAM Bits	6747840
Number of I/O	734
Number of Gates	-
Voltage - Supply	1.15V ~ 1.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	1508-BBGA, FCBGA
Supplier Device Package	1508-FBGA, FC (40x40)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep2sgx130gf40c5

1. Introduction

SIIGX51001-1.6

The Stratix® II GX family of devices is Altera's third generation of FPGAs to combine high-speed serial transceivers with a scalable, high-performance logic array. Stratix II GX devices include 4 to 20 high-speed transceiver channels, each incorporating clock and data recovery unit (CRU) technology and embedded SERDES capability at data rates of up to 6.375 gigabits per second (Gbps). The transceivers are grouped into four-channel transceiver blocks and are designed for low power consumption and small die size. The Stratix II GX FPGA technology is built upon the Stratix II architecture and offers a 1.2-V logic array with unmatched performance, flexibility, and time-to-market capabilities. This scalable, high-performance architecture makes Stratix II GX devices ideal for high-speed backplane interface, chip-to-chip, and communications protocol-bridging applications.

Features

This section lists the Stratix II GX device features.

- Main device features:
  - TriMatrix memory consisting of three RAM block sizes to implement true dual-port memory and first-in first-out (FIFO) buffers with performance up to 550 MHz
  - Up to 16 global clock networks with up to 32 regional clock networks per device region
  - High-speed DSP blocks provide dedicated implementation of multipliers (at up to 450 MHz), multiply-accumulate functions, and finite impulse response (FIR) filters
  - Up to four enhanced PLLs per device provide spread spectrum, programmable bandwidth, clock switch-over, real-time PLL reconfiguration, and advanced multiplication and phase shifting
  - Support for numerous single-ended and differential I/O standards
  - High-speed source-synchronous differential I/O support on up to 71 channels
  - Support for source-synchronous bus standards, including SPI-4 Phase 2 (POS-PHY Level 4), SFI-4.1, XSBI, UTOPIA IV, NPSI, and CSIX-L1
  - Support for high-speed external memory, including quad data rate (QDR and QDRII) SRAM, double data rate (DDR and DDR2) SDRAM, and single data rate (SDR) SDRAM

There are up to 20 transceiver channels available on a single Stratix II GX device. Table 2–1 shows the number of transceiver channels and their serial bandwidth for each Stratix II GX device.

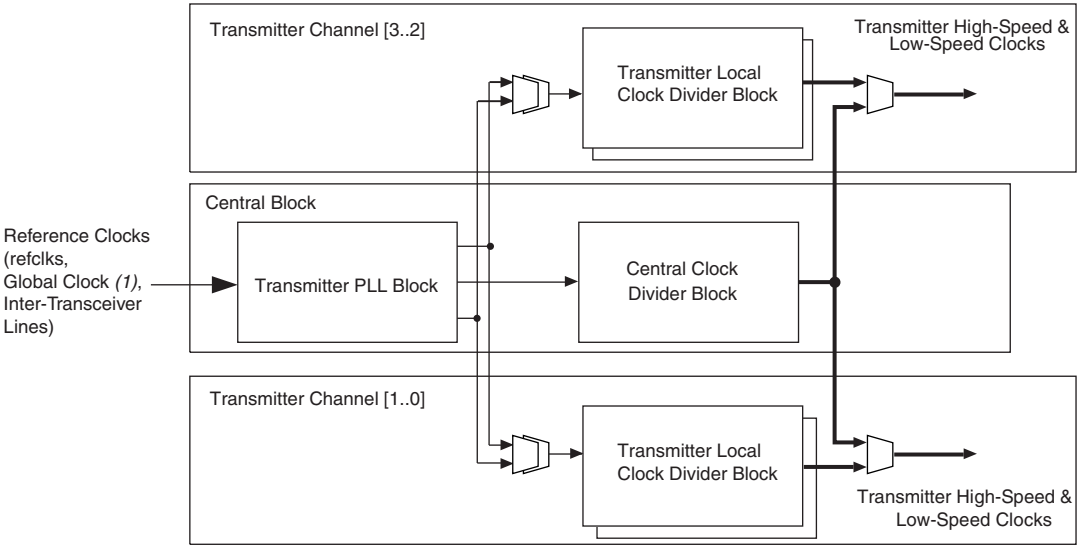
Table 2–1. Stratix II GX Transceiver Channels

Device	Number of Transceiver Channels	Serial Bandwidth (Full Duplex)
EP2SGX30C	4	51 Gbps
EP2SGX60C	4	51 Gbps
EP2SGX30D	8	102 Gbps
EP2SGX60D	8	102 Gbps
EP2SGX60E	12	153 Gbps
EP2SGX90E	12	153 Gbps
EP2SGX90F	16	204 Gbps
EP2SGX130G	20	255 Gbps

Figure 2–2 shows the elements of the transceiver block, including the four transceiver channels, supporting logic, and I/O buffers. Each transceiver channel consists of a receiver and transmitter. The supporting logic contains two transmitter PLLs to generate the high-speed clock(s) used by the four transmitters within that block. Each of the four transmitter channels has its own individual clock divider. The four receiver PLLs within each transceiver block generate four recovered clocks. The transceiver channels can be configured in one of the following functional modes:

- PCI Express (PIPE)
- OIF CEI PHY Interface
- SONET/SDH
- Gigabit Ethernet (GIGE)
- XAUI
- Basic (600 Mbps to 3.125 Gbps single-width mode and 1 Gbps to 6.375 Gbps double-width mode)
- SDI (HD, 3G)
- CPRI (614 Mbps, 1228 Mbps, 2456 Mbps)
- Serial RapidIO (1.25 Gbps, 2.5 Gbps, 3.125 Gbps)

Figure 2–3. Clock Distribution for the Transmitters Note (1)



Note to Figure 2–3:
(1) The global clock line must be driven by an input pin.

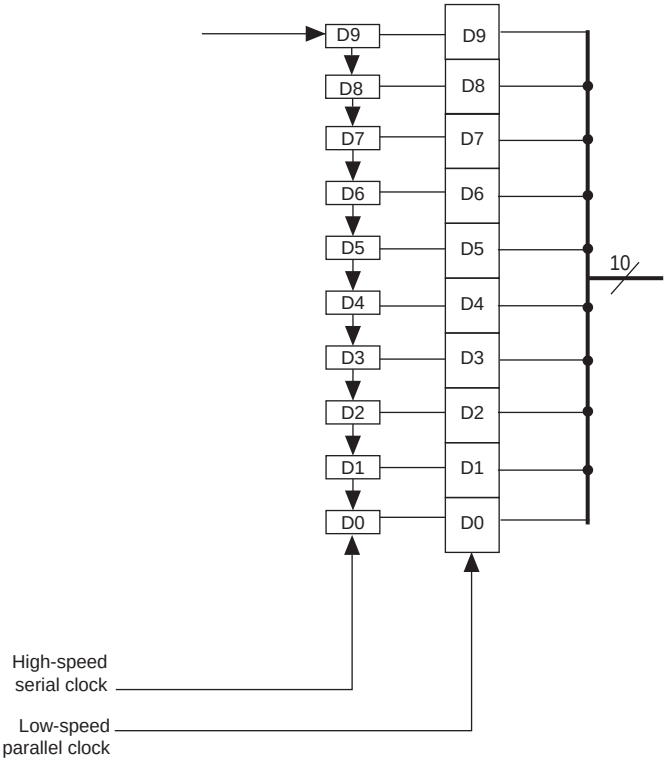
The transmitter PLLs in each transceiver block clock the PMA and PCS circuitry in the transmit path. The Quartus II software automatically powers down the transmitter PLLs that are not used in the design. Figure 2–4 is a block diagram of the transmitter PLL.

The transmitter phase/frequency detector references the clock from one of the following sources:

- Reference clocks
- Reference clock from the adjacent transceiver block
- Inter-transceiver block clock lines
- Global clock line driven by input pin

Two reference clocks, `REFCLK0` and `REFCLK1`, are available per transceiver block. The inter-transceiver block bus allows multiple transceivers to use the same reference clocks. Each transceiver block has one outgoing reference clock which connects to one inter-transceiver block line. The incoming reference clock can be selected from five inter-transceiver block lines `IQ[4..0]` or from the global clock line that is driven by an input pin.

Figure 2–17. Deserializer Note (1)

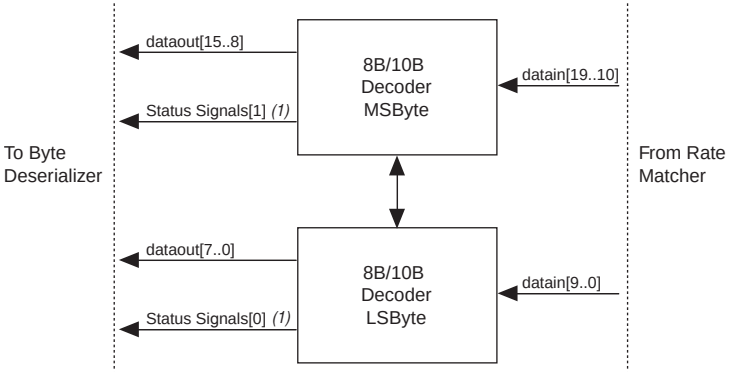


Note to Figure 2–17:
(1) This is a 10-bit deserializer. The deserializer can also convert 8, 16, or 20 bits of data.

Word Aligner

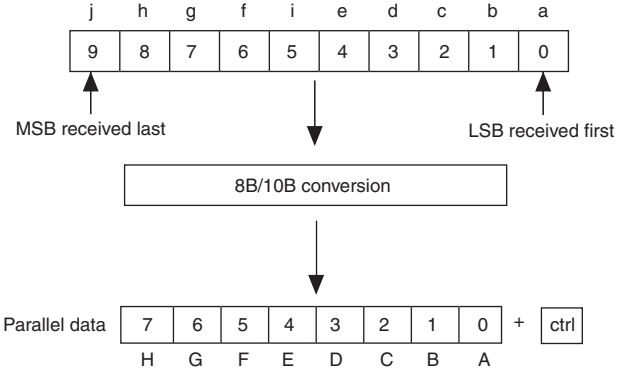
The deserializer block creates 8-, 10-, 16-, or 20-bit parallel data. The deserializer ignores protocol symbol boundaries when converting this data. Therefore, the boundaries of the transferred words are arbitrary. The word aligner aligns the incoming data based on specific byte or word boundaries. The word alignment module is clocked by the local receiver recovered clock during normal operation. All the data and programmed patterns are defined as big-endian (most significant word followed by least significant word). Most-significant-bit-first protocols such as SONET/SDH should reverse the bit order of word align patterns programmed.

Figure 2–21. 8B/10B Decoder



The 8B/10B decoder in single-width mode translates the 10-bit encoded data into the 8-bit equivalent data or control code. The 10-bit code received must be from the supported Dx.y or Kx.y list with the proper disparity or error flags asserted. All 8B/10B control signals, such as disparity error or control detect, are pipelined with the data and edge-aligned with the data. Figure 2–22 shows how the 10-bit symbol is decoded in the 8-bit data + 1-bit control indicator.

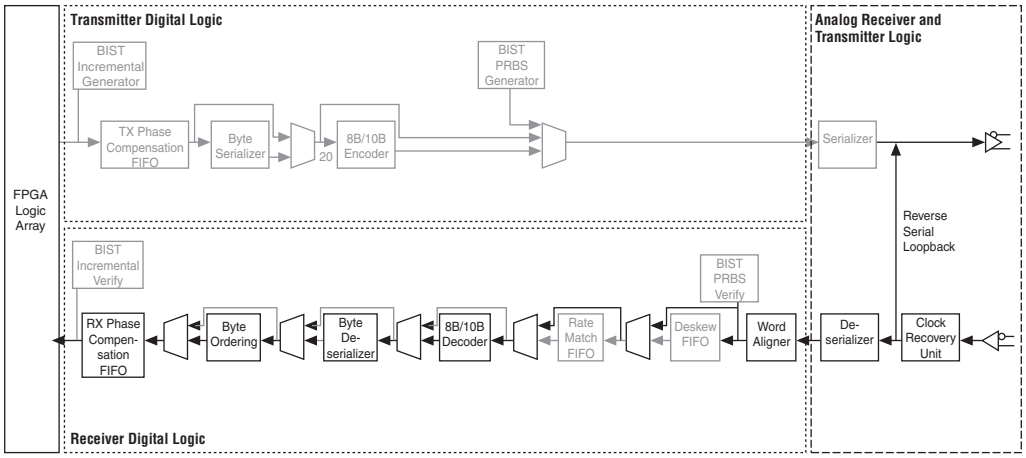
Figure 2–22. 8B/10B Decoder Conversion



The 8B/10B decoder in double-width mode translates the 20-bit (2 × 10-bits) encoded code into the 16-bit (2 × 8-bits) equivalent data or control code. The 20-bit upper and lower symbols received must be from the supported Dx.y or Kx.y list with the proper disparity or error flags

Figure 2–26 shows the data path in reverse serial loopback mode.

Figure 2–26. Stratix II GX Block in Reverse Serial Loopback Mode

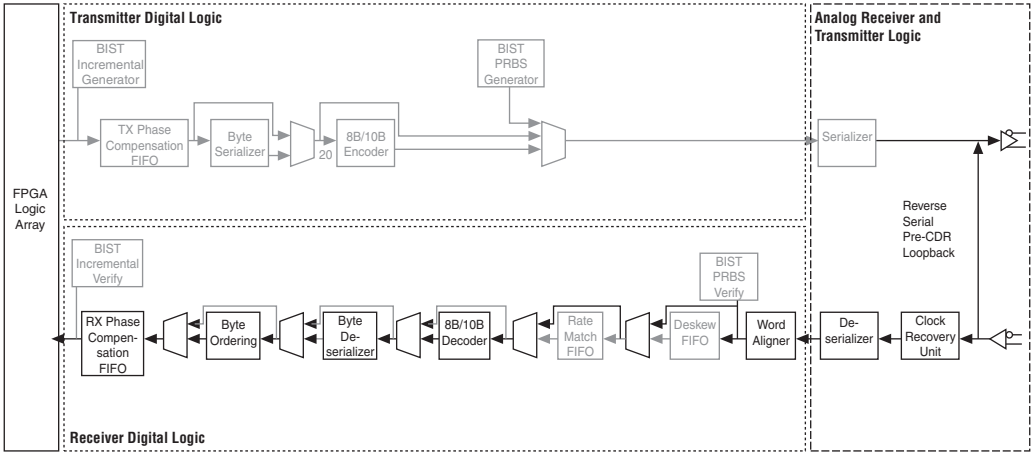


Reverse Serial Pre-CDR Loopback

The reverse serial pre-CDR loopback mode uses the analog portion of the transceiver. An external source (pattern generator or transceiver) generates the source data. The high-speed serial source data arrives at the high-speed differential receiver input buffer, loops back before the CRU unit, and is transmitted though the high-speed differential transmitter output buffer. It is for test or verification use only to verify the signal being received after the gain and equalization improvements of the input buffer. The signal at the output is not exactly what is received since the signal goes through the output buffer and the VOD is changed to the VOD setting level. The pre-emphasis settings have no effect.

Figure 2–27 show the Stratix II GX block in reverse serial pre-CDR loopback mode.

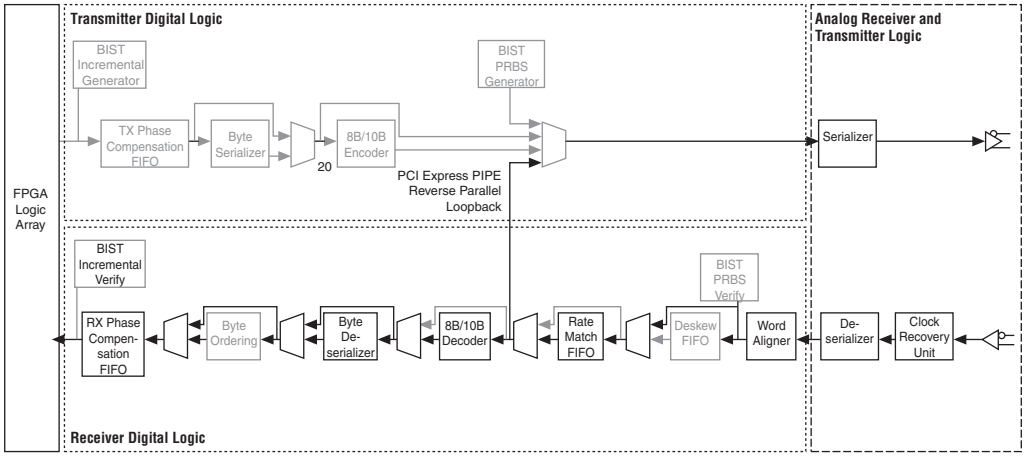
Figure 2–27. Stratix II GX Block in Reverse Serial Pre-CDR Loopback Mode



PCI Express PIPE Reverse Parallel Loopback

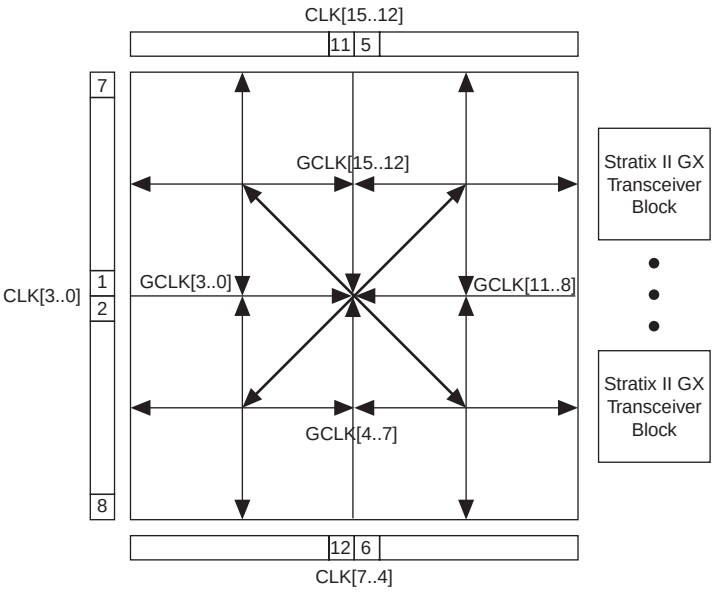
This loopback mode, available only in PIPE mode, can be dynamically enabled by the `tx_detectrxloopback` port of the PIPE interface. Figure 2–28 shows the datapath for this mode.

Figure 2–28. Stratix II GX Block in PCI Express PIPE Reverse Parallel Loopback Mode



The receiver PLL can also drive the regional clocks and regional routing adjacent to the associated transceiver block. Figure 2–30 shows which global clock resource can be used by the recovered clock. Figure 2–31 shows which regional clock resource can be used by the recovered clock.

Figure 2–30. Stratix II GX Receiver PLL Recovered Clock to Global Clock Connection *Notes (1), (2)*



Notes to Figure 2–30:

(1) CLK# pins are clock pins and their associated number. These are pins for global and regional clocks.

(2) GCLK# pins are global clock pins.

Table 2–11 summarizes the possible clocking connections for the transceivers.

Table 2–11. Available Clocking Connections for Transceivers

Source	Destination				
	Transmitter PLL	Receiver PLL	Global Clock	Regional Clock	Inter-Transceiver Lines
REFCLK[1..0]	✓	✓	✓	✓	✓
Transmitter PLL			✓	✓	
Receiver PLL			✓	✓	
Global clock (driven from an input pin)	✓	✓			
Inter-transceiver lines	✓	✓			

Clock Resource for PLD-Transceiver Interface

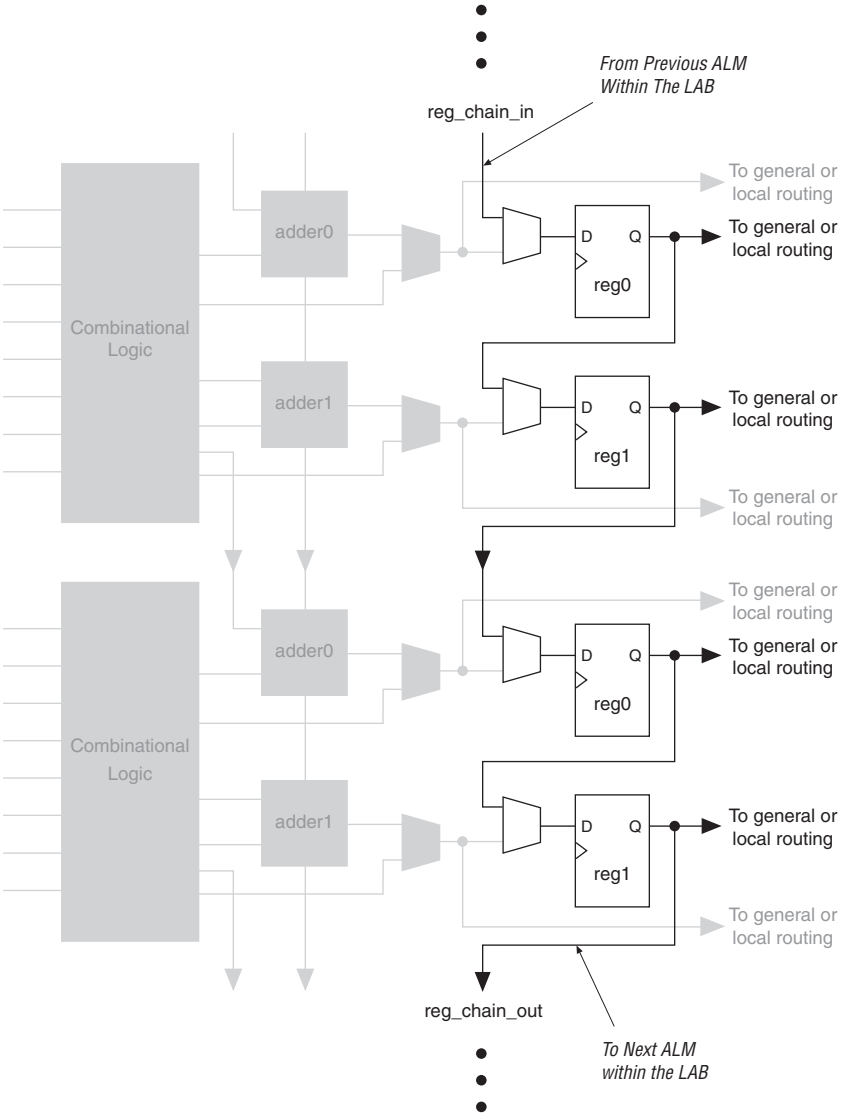
For the regional or global clock network to route into the transceiver, a local route input output (LRIO) channel is required. Each LRIO clock region has up to eight clock paths and each transceiver block has a maximum of eight clock paths for connecting with LRIO clocks. These resources are limited and determine the number of clocks that can be used between the PLD and transceiver blocks. Table 2–12 shows the number of LRIO resources available for Stratix II GX devices with different numbers of transceiver blocks.

Tables 2–12 through 2–15 show the connection of the LRIO clock resource to the transceiver block.

Table 2–12. Available Clocking Connections for Transceivers in 2SGX30D

Region	Clock Resource		Transceiver	
	Global Clock	Regional Clock	Bank 13 8 Clock I/O	Bank 14 8 Clock I/O
Region0 8 LRIO clock	✓	RCLK 20-27	✓	
Region1 8 LRIO clock	✓	RCLK 12-19		✓

Figure 2–45. Register Chain within a LAB *Note (1)*



Note to Figure 2–45:
(1) The combinational or adder logic can be utilized to implement an unrelated, un-registered function.

- Differential SSTL-2 class I and II
- 1.2-V HSTL class I and II
- 1.5-V HSTL class I and II
- 1.8-V HSTL class I and II
- SSTL-2 class I and II
- SSTL-18 class I and II

Table 2–33 describes the I/O standards supported by Stratix II GX devices.

Table 2–33. Stratix II GX Supported I/O Standards

I/O Standard	Type	Input Reference Voltage (V_{REF}) (V)	Output Supply Voltage (V_{CCIO}) (V)	Board Termination Voltage (V_{TT}) (V)
LVTTL	Single-ended	—	3.3	—
LVCMOS	Single-ended	—	3.3	—
2.5 V	Single-ended	—	2.5	—
1.8 V	Single-ended	—	1.8	—
1.5-V LVCMOS	Single-ended	—	1.5	—
3.3-V PCI	Single-ended	—	3.3	—
3.3-V PCI-X mode 1	Single-ended	—	3.3	—
LVDS	Differential	—	2.5 *(3)*	—
LVPECL *(1)*	Differential	—	3.3	—
HyperTransport technology	Differential	—	2.5 *(3)*	—
Differential 1.5-V HSTL class I and II *(2)*	Differential	0.75	1.5	0.75
Differential 1.8-V HSTL class I and II *(2)*	Differential	0.90	1.8	0.90
Differential SSTL-18 class I and II *(2)*	Differential	0.90	1.8	0.90
Differential SSTL-2 class I and II *(2)*	Differential	1.25	2.5	1.25
1.2-V HSTL*(4)*	Voltage-referenced	0.6	1.2	0.6
1.5-V HSTL class I and II	Voltage-referenced	0.75	1.5	0.75
1.8-V HSTL class I and II	Voltage-referenced	0.9	1.8	0.9
SSTL-18 class I and II	Voltage-referenced	0.90	1.8	0.90

DC Electrical Characteristics

Table 4–23 shows the Stratix II GX device family DC electrical characteristics.

Table 4–23. Stratix II GX Device DC Operating Conditions (Part 1 of 2) *Note (1)*

Symbol	Parameter	Conditions	Device	Minimum	Typical	Maximum	Unit
I_I	Input pin leakage current	$V_I = V_{CCIOmax}$ to 0 V *(2)*	All	–10		10	µA
I_{OZ}	Tri-stated I/O pin leakage current	$V_O = V_{CCIOmax}$ to 0 V *(2)*	All	–10		10	µA
I_{CCINT0}	V_{CCINT} supply current (standby)	V_I = ground, no load, no toggling inputs T_J = 25 °C	EP2SGX30		0.30	*(3)*	A
			EP2SGX60		0.50	*(3)*	A
			EP2SGX90		0.62	*(3)*	A
			EP2SGX130		0.82	*(3)*	A
I_{CCPD0}	V_{CCPD} supply current (standby)	V_I = ground, no load, no toggling inputs T_J = 25 °C, V_{CCPD} = 3.3V	EP2SGX30		2.7	*(3)*	mA
			EP2SGX60		3.6	*(3)*	mA
			EP2SGX90		4.3	*(3)*	mA
			EP2SGX130		5.4	*(3)*	mA
I_{CCIO0}	V_{CCIO} supply current (standby)	V_I = ground, no load, no toggling inputs T_J = 25 °C	EP2SGX30		4.0	*(3)*	mA
			EP2SGX60		4.0	*(3)*	mA
			EP2SGX90		4.0	*(3)*	mA
			EP2SGX130		4.0	*(3)*	mA

Table 4–32. LVPECL Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V_{CCIO} *(1)*	I/O supply voltage		3.135	3.3	3.465	V
V_{ID}	Input differential voltage swing (single-ended)		300	600	1,000	mV
V_{ICM}	Input common mode voltage		1.0		2.5	V
V_{OD}	Output differential voltage (single-ended)	R_L = 100 Ω	525		970	mV
V_{OCM}	Output common mode voltage	R_L = 100 Ω	1,650		2,250	mV
R_L	Receiver differential input resistor		90	100	110	Ω

Note to Table 4–32:

(1) The top and bottom clock input differential buffers in I/O banks 3, 4, 7, and 8 are powered by V_{CCINT}, not V_{CCIO}. The PLL clock output/feedback differential buffers are powered by VCC_PLL_OUT. For differential clock output/feedback operation, connect VCC_PLL_OUT to 3.3 V.

Table 4–33. 3.3-V PCI Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V_{CCIO}	Output supply voltage		3.0	3.3	3.6	V
V_{IH}	High-level input voltage		0.5 V_{CCIO}		V_{CCIO} + 0.5	V
V_{IL}	Low-level input voltage		–0.3		0.3 V_{CCIO}	V
V_{OH}	High-level output voltage	I_{OUT} = –500 µA	0.9 V_{CCIO}			V
V_{OL}	Low-level output voltage	I_{OUT} = 1,500 µA			0.1 V_{CCIO}	V

Table 4–34. PCI-X Mode 1 Specifications

Symbol	Parameter	Conditions	Minimum	Typical	Maximum	Unit
V_{CCIO}	Output supply voltage		3.0		3.6	V
V_{IH}	High-level input voltage		0.5 V_{CCIO}		V_{CCIO} + 0.5	V
V_{IL}	Low-level input voltage		–0.3		0.35 V_{CCIO}	V
V_{IPU}	Input pull-up voltage		0.7 V_{CCIO}			V
V_{OH}	High-level output voltage	I_{OUT} = –500 µA	0.9 V_{CCIO}			V
V_{OL}	Low-level output voltage	I_{OUT} = 1,500 µA			0.1 V_{CCIO}	V

Table 4–58. DSP Block Internal Timing Microparameters (Part 2 of 2)

Symbol	Parameter	-3 Speed Grade (1)		-3 Speed Grade (2)		-4 Speed Grade		-5 Speed Grade		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	
$t_{INREG2PIPE9}$	Input register to DSP block pipeline register in 9 × 9-bit mode	1312	2030	1312	2131	1312	2266	1312	2720	ps
$t_{INREG2PIPE18}$	Input register to DSP block pipeline register in 18 × 18-bit mode	1302	2010	1302	2110	1302	2244	1302	2693	ps
$t_{INREG2PIPE36}$	Input register to DSP block pipeline register in 36 × 36-bit mode	1302	2010	1302	2110	1302	2244	1302	2693	ps
$t_{PIPE2OUTREG2ADD}$	DSP block pipeline register to output register delay in two-multipliers adder mode	924	1450	924	1522	924	1618	924	1943	ps
$t_{PIPE2OUTREG4ADD}$	DSP block pipeline register to output register delay in four-multipliers adder mode	1134	1850	1134	1942	1134	2065	1134	2479	ps
t_{PD9}	Combinational input to output delay for 9 × 9	2100	2880	2100	3024	2100	3214	2100	3859	ps
t_{PD18}	Combinational input to output delay for 18 × 18	2110	2990	2110	3139	2110	3337	2110	4006	ps
t_{PD36}	Combinational input to output delay for 36 × 36	2939	4450	2939	4672	2939	4967	2939	5962	ps
t_{CLR}	Minimum clear pulse width	2212		2322		2469		2964		ps
t_{CLKL}	Minimum clock low time	1190		1249		1328		1594		ps
t_{CLKH}	Minimum clock high time	1190		1249		1328		1594		ps

(1) This column refers to –3 speed grades for EP2SGX30, EP2SGX60, and EP2SGX90 devices.
(2) This column refers to –3 speed grades for EP2SGX130 devices.

Table 4–61. M-RAM Block Internal Timing Microparameters (Part 2 of 2) *Note (1)*

Symbol	Parameter	-3 Speed Grade *(2)*		-3 Speed Grade *(3)*		-4 Speed Grade		-5 Speed Grade		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	
$t_{MEGABESU}$	Byte enable setup time before clock	-9		-10		-11		-13		ps
$t_{MEGABEH}$	Byte enable hold time after clock	39		40		43		52		ps
$t_{MEGADATAASU}$	A port data setup time before clock	50		52		55		67		ps
$t_{MEGADATAAH}$	A port data hold time after clock	243		255		271		325		ps
$t_{MEGAADDRASU}$	A port address setup time before clock	589		618		657		789		ps
$t_{MEGAADDRAH}$	A port address hold time after clock	-347		-365		-388		-465		ps
$t_{MEGADATABSU}$	B port setup time before clock	50		52		55		67		ps
$t_{MEGADATABH}$	B port hold time after clock	243		255		271		325		ps
$t_{MEGAADDRBSU}$	B port address setup time before clock	589		618		657		789		ps
$t_{MEGAADDRBH}$	B port address hold time after clock	-347		-365		-388		-465		ps
$t_{MEGADATACO1}$	Clock-to-output delay when using output registers	480	715	480	749	480	797	480	957	ps
$t_{MEGADATACO2}$	Clock-to-output delay without output registers	1950	2899	1950	3042	1950	3235	1950	3884	ps
$t_{MEGACLKL}$	Minimum clock low time	1250		1312		1395		1675		ps
$t_{MEGACLKH}$	Minimum clock high time	1250		1312		1395		1675		ps
$t_{MEGACLR}$	Minimum clear pulse width	144		151		160		192		ps

(1) The M512 block f_{MAX} obtained using the Quartus II software does not necessarily equal to 1/TMEGARC.
(2) This column refers to –3 speed grades for EP2SGX30, EP2SGX60, and EP2SGX90 devices.
(3) This column refers to –3 speed grades for EP2SGX130 devices.

Table 4–79. Clock Network Specifications (Part 2 of 2)					
Name	**Description**	**Min**	**Typ**	**Max**	**Unit**
Clock skew adder EP2SGX130 *(1)*	Inter-clock network, same side			±63	ps
	Inter-clock network, entire chip			±125	ps

(1) This is in addition to intra-clock network skew, which is modeled in the Quartus II software.

IOE Programmable Delay

See Tables 4–80 and 4–81 for IOE programmable delay.

Table 4–80. Stratix II GX IOE Programmable Delay on Column Pins *Note (1)*													
Parameter	**Paths Affected**	**Available Settings**	**Minimum Timing**		**-3 Speed Grade** *(2)*		**-3 Speed Grade** *(3)*		**-4 Speed Grade**		**-5 Speed Grade**		**Unit**
			Min Offset	**Max Offset**	**Min Offset**	**Max Offset**	**Min Offset**	**Max Offset**	**Min Offset**	**Max Offset**	**Min Offset**	**Max Offset**	
Input delay from pin to internal cells	Pad to I/O dataout to core	8	0	1781	0	2881	0	3025	0	3217	0	3,860	ps
Input delay from pin to input register	Pad to I/O input register	64	0	2053	0	3275	0	3439	0	3657	0	4388	ps
Delay from output register to output pin	I/O output register to pad	2	0	332	0	500	0	525	0	559	0	670	ps
Output enable pin delay	t_{XZ}, t_{ZX}	2	0	320	0	483	0	507	0	539	0	647	ps

(1) The incremental values for the settings are generally linear. For the exact delay associated with each setting, use the latest version of the Quartus II software.
(2) This column refers to –3 speed grades for EP2SGX30, EP2SGX60, and EP2SGX90 devices.
(3) This column refers to –3 speed grades for EP2SGX130 devices.

To calculate the output toggle rate for a non 0 pF load, use this formula:

The toggle rate for a non 0 pF load

= 1,000 / (1,000/ toggle rate at 0 pF load + derating factor × load value in pF /1,000)

For example, the output toggle rate at 0 pF load for SSTL-18 Class II 20 mA I/O standard is 550 MHz on a -3 device clock output pin. The derating factor is 94 ps/pF. For a 10 pF load the toggle rate is calculated as:

1,000 / (1,000/550 + 94 × 10 /1,000) = 363 (MHz)

Table 4–88 shows the maximum input clock toggle rates for Stratix II GX device column pins.

Table 4–88. Stratix II GX Maximum Input Clock Rate for Column I/O Pins (Part 1 of 2)

I/O Standard	-3 Speed Grade	-4 Speed Grade	-5 Speed Grade	Unit
LVTTL	500	500	450	MHz
2.5 V	500	500	450	MHz
1.8 V	500	500	450	MHz
1.5 V	500	500	450	MHz
LVCMOS	500	500	450	MHz
SSTL-2 Class I	500	500	500	MHz
SSTL-2 Class II	500	500	500	MHz
SSTL-18 Class I	500	500	500	MHz
SSTL-18 Class I I	500	500	500	MHz
1.5-V HSTL Class I	500	500	500	MHz
1.5-V HSTL Class I I	500	500	500	MHz
1.8-V HSTL Class I	500	500	500	MHz
1.8-V HSTL Class II	500	500	500	MHz
PCI	500	500	450	MHz
PCI-X	500	500	450	MHz
Differential SSTL-2 Class I	500	500	500	MHz
Differential SSTL-2 Class II	500	500	500	MHz
Differential SSTL-18 Class I	500	500	500	MHz

Table 4–111. Fast PLL Specifications (Part 2 of 2)					
Name	**Description**	**Min**	**Typ**	**Max**	**Unit**
f_{VCO}	Upper VCO frequency range for –3 and –4 speed grades	300		1,040	MHz
	Upper VCO frequency range for –5 speed grades	300		840	MHz
	Lower VCO frequency range for –3 and –4 speed grades	150		520	MHz
	Lower VCO frequency range for –5 speed grades	150		420	MHz
f_{OUT}	PLL output frequency to GCLK or RCLK	4.6875		550	MHz
	PLL output frequency to LVDS or DPA clock	150		1,040	MHz
f_{OUT_EXT}	PLL clock output frequency to regular I/O	4.6875		*(1)*	MHz
$t_{CONFIGPLL}$	Time required to reconfigure scan chains for fast PLLs		$75/f_{SCANCLK}$		ns
f_{CLBW}	PLL closed-loop bandwidth	1.16	5	28	MHz
t_{LOCK}	Time required for the PLL to lock from the time it is enabled or the end of the device configuration		0.03	1	ms
t_{PLL_PSERR}	Accuracy of PLL phase shift			±30	ps
t_{ARESET}	Minimum pulse width on areset signal.	10			ns
$t_{ARESET\_RECONFIG}$	Minimum pulse width on the areset signal when using PLL reconfiguration. Reset the PLL after scandone goes high.	500			ns

(1) This is limited by the I/O f_{MAX}. See Tables 4–91 through 4–95 for the maximum.

External Memory Interface Specifications

Tables 4–112 through 4–116 contain Stratix II GX device specifications for the dedicated circuitry used for interfacing with external memory devices.

Table 4–112. DLL Frequency Range Specifications (Part 1 of 2)		
Frequency Mode	**Frequency Range (MHz)**	**Resolution (Degrees)**
0	100 to 175	30
1	150 to 230	22.5
2	200 to 350 (–3 speed grade)	30
	200 to 310 (–4 and –5 speed grade)	30

Document Revision History

Table 6–105 shows the revision history for this chapter.

Table 4–118. Document Revision History (Part 1 of 5)

Date and Document Version	Changes Made	Summary of Changes
June 2009 v4.6	Replaced Table 4–31 Updated: • Table 4–5 • Table 4–6 • Table 4–7 • Table 4–8 • Table 4–9 • Table 4–10 • Table 4–11 • Table 4–12 • Table 4–13 • Table 4–14 • Table 4–15 • Table 4–16 • Table 4–17 • Table 4–18 • Table 4–20 • Table 4–50 • Table 4–95 • Table 4–105 • Table 4–110 • Table 4–111	
October 2007 v4.5	Updated: • Table 4–3 • Table 4–6 • Table 4–16 • Table 4–19 • Table 4–20 • Table 4–21 • Table 4–22 • Table 4–55 • Table 4–106 • Table 4–107 • Table 4–108 • Table 4–109 • Table 4–112	
	Updated title only in Tables 4–88 and 4–89.	
	Minor text edits.	